IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: To be Assigned Examiner: To be Assigned

#ZA NEGC

In	Re	PATENT	APPL	ICATION	Of:

Applicant : Minoru WATANABE

Appln. No. : Continuation of Serial No. 09/443,500

Filed : Herewith) PRELIMINARY) AMENDMENT

For : METHOD AND APPARATUS FOR

FORMING RESIST PATTERN

Attorney Ref.: MAE 223 C1

Commissioner for Patents Washington, D.C. 20231

Sir:

fü

Preliminary to examination, please amend the application as follows:

IN THE SPECIFICATION:

Please amend page 1 of the specification to read as follows:

-- This application is a continuation of application serial number 09/443,500, which was filed on November 19, 1999.--

IN THE CLAIMS

Please cancel claims 2-4 without prejudice or disclaimer to the subject matter recited therein.

Please amend claim 1 as follows:

1. (Amended) A method of forming a resist pattern on a semiconductor substrate, comprising:

forming a resist film on the semiconductor substrate;

supplying a developing solution on the resist film to remove the resist film, wherein a portion of the resist film remains on the semiconductor substrate; and

A